12/3/2015



# PRODUCT RELIABILITY REPORT FOR

# 71M6541G

# **Maxim Integrated**

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Approved by:

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## **Conclusion:**

The following qualification successfully meets the quality and reliability standards required of all Maxim Integrated products:

#### 71M6541G

In addition, Maxim Integrated's continuous reliability monitor program ensures that all outgoing product will continue to meet Maxim's quality and reliability standards. The current status of the reliability monitor program can be viewed at http://www.maximintegrated.com/qa/reliability/monitor.

#### **Device Description:**

A description of this device can be found in the product data sheet. You can find the product data sheet at http://www.maximintegrated.com/search/parts.mvp.

### **Reliability Derating:**

The Arrhenius model will be used to determine the acceleration factor for failure mechanisms that are temperature accelerated.

AfT = exp((Ea/k)\*(1/Tu - 1/Ts)) = tu/ts AfT = Acceleration factor due to Temperature tu = Time at use temperature (e.g. 55°C) ts = Time at stress temperature (e.g. 125°C) k = Boltzmann's Constant (8.617 x 10-5 eV/°K) Tu = Temperature at Use (°K) Ts = Temperature at Stress (°K) Ea = Activation Energy (e.g. 0.7 ev)

The activation energy of the failure mechanism is derived from either internal studies or industry accepted standards, or activation energy of 0.7ev will be used whenever actual failure mechanisms or their activation energies are unknown. All deratings will be done from the stress ambient temperature to the use ambient temperature.

An exponential model will be used to determine the acceleration factor for failure mechanisms, which are voltage accelerated.

AfV = exp(B\*(Vs - Vu)) AfV = Acceleration factor due to Voltage Vs = Stress Voltage (e.g. 7.0 volts) Vu = Maximum Operating Voltage (e.g. 5.5 volts) B = Constant related to failure mechanism type (e.g. 1.0, 2.4, 2.7, etc.)

The Constant, B, related to the failure mechanism is derived from either internal studies or industry accepted standards, or a B of 1.0 will be used whenever actual failure mechanisms or their B are unknown. All deratings will be done from the stress voltage to the maximum operating voltage. Failure rate data from the operating life test is reported using a Chi-Squared statistical model at the 60% or 90% confidence level (Cf).

The failure rate, Fr, is related to the acceleration during life test by:

Fr = X/(ts \* AfV \* AfT \* N \* 2) X = Chi-Sq statistical upper limit N = Life test sample size Failure Rates are reported in FITs (Failures in Time) or MTTF (Mean Time To Failure). The FIT rate is related to MTTF by:

MTTF = 1/Fr

NOTE: MTTF is frequently used interchangeably with MTBF.

The calculated failure rate for this device/process is:

FAI	LURE RATE:	MTTF (YRS	5): 373420	FITS:	0.3				
		<b>DEVICE HOUR</b>	S: 2997332272	FAILS:	0				
Only data from Operating Life or similar stresses are used for this calculation.									
The parameters used to calculate this failure rate are as follows:									
Cf:	60%	Ea: 0.7 B: 0	Tu:	25 °C	Vu: 3.6	Volts			

The reliability data follows. At the start of this data is the device information. The next section is the detailed reliability data for each stress. The reliability data section includes the latest data available and may contain some generic data. **Bold** Product Number denotes specific product data.

Device Informatio	n:										
Process:	TSMC (	TSMC 0.25um, Mixed signal, Embedded flash, General Purpose									
Passivation:	SiO/SiN	SiO/SiN = 1000nm/700nm									
Die Size:		126 x 1	126 x 176								
Number of Trans	istors:	170291	1702915								
Interconnect:		Aluminu	Aluminum / 0.5% Copper								
Gate Oxide Thickness:		70 Å	70 Å								
ESD HBM											
DESCRIPTION DATE COD		CODE/PRODU	CT/LOT	CONDITION	READPOIN		QTY	FAILS	FA#		
ESD SENSITIVITY	1052	71M6543G	445AN	JESD22-A114 HBM 500 VOLTS	1	PUL'S	5	0			
ESD SENSITIVITY	1052	71M6543G	445AN	JESD22-A114 HBM 1000 VOLTS	1	PUL'S	5	0			
ESD SENSITIVITY	1052	71M6543G	445AN	JESD22-A114 HBM 1500 VOLTS	1	PUL'S	5	0			
ESD SENSITIVITY	1052	71M6543G	445AN	JESD22-A114 HBM 2000 VOLTS	1	PUL'S	5	0			
ESD SENSITIVITY	1052	71M6543G	445AN	JESD22-A114 HBM 2500 VOLTS	1	PUL'S	5	0			
ESD SENSITIVITY	1052	71M6543G	445AN	JESD22-A114 HBM 3000 VOLTS	1	PUL'S	5	0			
					Total:			0			
LATCH-UP											
DESCRIPTION	CRIPTION DATE CODE/PRODUCT/LOT			CONDITION	READPOIN		QTY	FAILS	FA#		
LATCH-UP I	1052	71M6543G	445AN	JESD78A, I-TEST 25C 100mA			6	0			
LATCH-UP I	1052	71M6543G	445AN	JESD78A, I-TEST 25C 250mA			6	0			
LATCH-UP V	1052	71M6543G	445AN	JESD78A, V-SUPPLY TEST 25C			6	0			
					Tota	I:		0			

OPERATING LIFE										
DESCRIPTION	DATE	CODE/PRODUCT/	LOT	CONDI	TION	READ	POIN	QTY	FAILS	FA#
HIGH TEMP OP LIFE	0222	78M6613	26728	125C, 3	3.6 VOLTS	1000	HRS	76	0	
HIGH TEMP OP LIFE	1026	71M6103	26803	125C, 3	3.3 VOLTS	500	HRS	200	0	
HIGH TEMP OP LIFE	1042	71M6543	QB112428AE	125C, 3	3.3 VOLTS	500	HRS	100	0	
HIGH TEMP OP LIFE	1052	71M6543G	445AN	125C, 3	6.6 VOLTS	192	HRS	77	0	
HIGH TEMP OP LIFE	1118	78M6631	GW110677A	125C, 5	5.0 VOLTS	1000	HRS	1690	0	
HIGH TEMP OP LIFE	1131	71M6543	GW112093A	125C, 3	3.5 VOLTS	500	HRS	77	0	
HIGH TEMP OP LIFE	1131	71M6543	GW112093A	125C, 3	3.6 VOLTS	1000	HRS	77	0	
HIGH TEMP OP LIFE	1131	71M6543	GW112093A	125C, 3	3.5 VOLTS	500	HRS	77	0	
HIGH TEMP OP LIFE	1131	71M6543	GW112093A	125C, 3	3.6 VOLTS	1000	HRS	77	0	
HIGH TEMP OP LIFE	1132	71M6543	GW112093A	125C, 3	3.5 VOLTS	500	HRS	77	0	
HIGH TEMP OP LIFE	1132	71M6543	GW112093A	125C, 3	8.6 VOLTS	1000	HRS	77	0	
HIGH TEMP OP LIFE	1209	78M6611	QX128420AB	125C, 3	3.6 VOLTS	1000	HRS	77	0	
HIGH TEMP OP LIFE	1209	78M6611	QX128420A	125C, 3	3.6 VOLTS	1000	HRS	77	0	
HIGH TEMP OP LIFE	1209	78M6611	QX128420A	125C, 3	8.6 VOLTS	1000	HRS	77	0	
HIGH TEMP OP LIFE	1219	78M6610	ZJ123342BC	125C, 3	8.6 VOLTS	192	HRS	80	0	
HIGH TEMP OP LIFE	1235	MAX78615	ZJ123499AC	125C, 3	8.6 VOLTS	192	HRS	80	0	
HIGH TEMP OP LIFE	1236	71M6542FT	Z4133579DA	125C, 3	8.6 VOLTS	192	HRS	80	0	
HIGH TEMP OP LIFE	1248	MAX78700	ZJ146362AB-	125C, 3	8.6 VOLTS	192	HRS	80	0	
HIGH TEMP OP LIFE	1250	MAX78700	ZJ133523ED	125C, 3	6.6 VOLTS	192	HRS	80	0	
HIGH TEMP OP LIFE	1330	71M6543GT	Z4136129AG	125C, 3	6.6 VOLTS	192	HRS	80	0	
HIGH TEMP OP LIFE	1515	71M6542FT	Z4140160AD	125C, 3	8.6 VOLTS	1000	HRS	77	0	
HIGH TEMP OP LIFE	1515	71M6542FT	Z4140160AE	125C, 3	8.6 VOLTS	1000	HRS	77	0	
HIGH TEMP OP LIFE	1515	71M6542FT	Z4140160AF	125C, 3	8.6 VOLTS	1000	HRS	77	0	
				400		Total:			0	
FAILUKE KATE:	_		3/3	420	FII5:	0.3				
	D	EVICE HOURS	: 2997332	272	FAILS:	0				

71M6541G is built with the identical die of 71M6543G